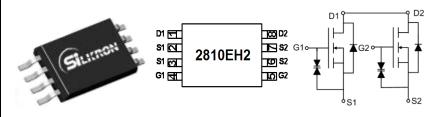


Main Product Characteristics:

V _{DSS}	20V
R _{DS} (on)	10mΩ (typ.)
I _D	8A ①



TSSOP-8

Marking and pin
Assignment

Schematic diagram

Features and Benefits:

- Advanced MOSFET process technology
- Ultra low on-resistance with low gate charge
- High Power and current handing capability
- 150°C operating temperature
- G/S ESD protect 2KV (HBM)



Description:

The SSF2810EH2 series MOSFETs is a new technology, which combines an innovative technology and advance process. This new technology achieves low Rdson, energy saving, high reliability and uniformity, superior power density and space saving.

Absolute max Rating:

Symbol	Parameter	Max.	Units	
I _D @ TC = 25°C	Continuous Drain Current	8 ①		
I _D @ TC = 100°C	TC = 100°C Continuous Drain Current		Α	
I _{DM}	Pulsed Drain Current ②	25		
D @TC 25°C	Power Dissipation ③	2	W	
P _D @TC = 25°C	Linear Derating Factor	0.5	W/°C	
V _{DS}	Drain-Source Voltage	20	V	
V _{GS}	Gate-to-Source Voltage	± 10	V	
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C	

Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-ambient (t \leq 10s) \oplus	1	90	°C/W





Electrical Characterizes $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source breakdown voltage	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
		_	10	14	mΩ	V_{GS} =4.5 V , I_{D} = 8 A
		_	20	_		T _J = 125°C
Б	Static Proin to Course on registeres	_	14	18	0	$V_{GS}=2.5V, I_D=6.5A$
$R_{DS(on)}$	Static Drain-to-Source on-resistance	_	25	_	mΩ	T _J = 125°C
		_	20	23	~ 0	$V_{GS}=1.8V, I_{D}=6A$
		_	38	_	mΩ	T _J = 125°C
$V_{GS(th)}$	Gate threshold voltage	0.6	_	1	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
-	Drain to Source leakage ourrent	_	_	1		$V_{DS} = 20V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source leakage current	_	_	50	μA	T _J = 125°C
		_	_	100	nA	V _{GS} = 4.5V
	Coto to Course forward balls as	_	_	-100		V _{GS} = -4.5V
I_{GSS}	Gate-to-Source forward leakage	_	_	10		V _{GS} = 10V
		_	_	-10	uA	V _{GS} = -10V
Q_g	Total gate charge	_	10	_		$I_D = 8A$,
Q_{gs}	Gate-to-Source charge	_	2.3	_	nC	V _{DS} =10V,
Q_{gd}	Gate-to-Drain("Miller") charge	_	3	_		$V_{GS} = 4.5V$
t _{d(on)}	Turn-on delay time	_	8.1	_		
t _r	Rise time	_	49	_	ns	V_{GS} =4.5V, V_{DS} =10V,
$t_{\text{d(off)}}$	Turn-Off delay time	_	26	_		$R_{GEN}=3\Omega, I_D=6.5$
t _f	Fall time	_	8.7	_		
C _{iss}	Input capacitance	_	950	_		$V_{GS} = 0V$
Coss	Output capacitance		209	_	pF	V _{DS} = 10V
C _{rss}	Reverse transfer capacitance		100	_		f = 1MHz

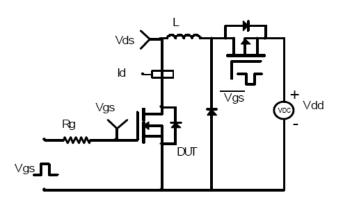
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
1	Continuous Source Current			0.0	^	MOSFET symbol
I _S	(Body Diode)	_	_	8 ①	Α	showing the
1	Pulsed Source Current			25	٨	integral reverse
I _{SM}	(Body Diode)	_	_	25	A	p-n junction diode.
$V_{\scriptscriptstyle{SD}}$	Diode Forward Voltage	_	_	1.2	V	I _S =2.8A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	_	35	_	nS	$T_J = 25^{\circ}C, I_F = 1A,$
Q _{rr}	Reverse Recovery Charge	_	7.2	_	nC	di/dt = 100A/μs

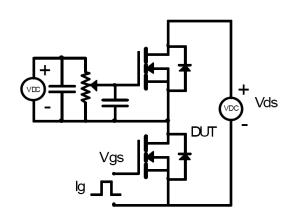


Test circuits and Waveforms

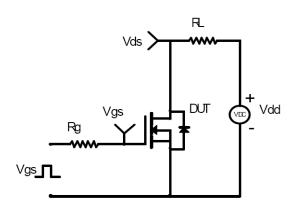
EAS Test Circuit:



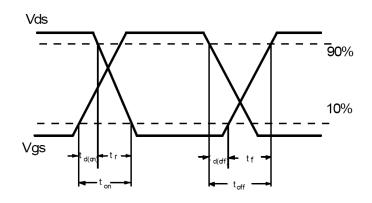
Gate charge test circuit:



Switching Time Test Circuit:



Switching Waveforms:

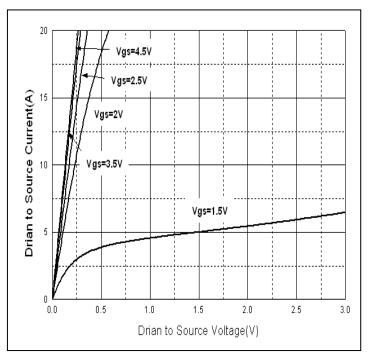


Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- 4The value of $R_{\texttt{6JA}}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C



Typical electrical and thermal characteristics



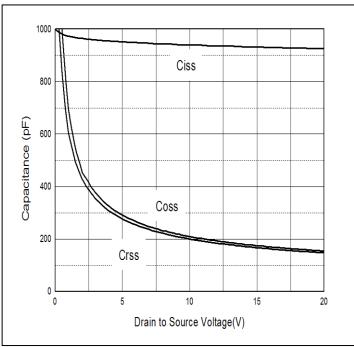
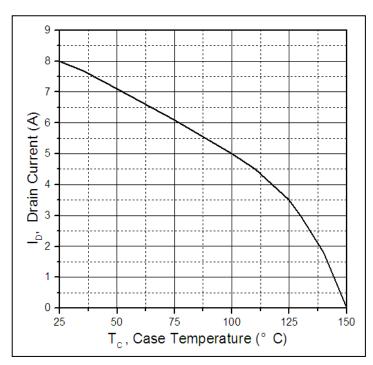


Figure 1: Typical Output Characteristics

Figure 2. Typical Capacitance Vs. Drain-to-Source Voltage





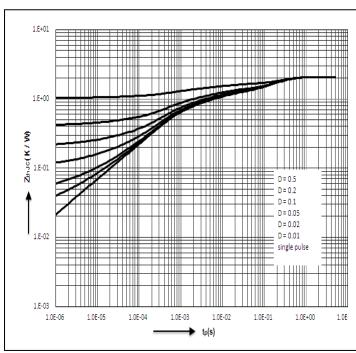
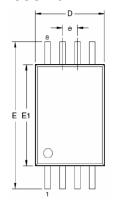


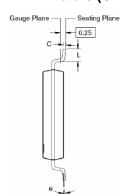
Figure4. Maximum Effective Transient Thermal Impedance, Junction-to-Case

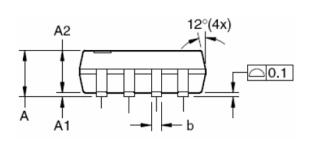


Mechanical Data:

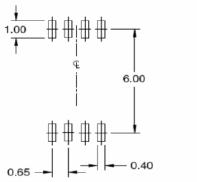
TSSOP-8 Dimensions in Millimeters (UNIT:mm)







RECOMMENDED LAND PATTERN



UNIT: mm

Dimensions in millimeters

Symbols	Min.	Nom.	Max.	
Α	_	_	1.20	
A1	0.05	_	0.15	
A2	0.80	1.00	1.05	
b	0.19	_	0.30	
С	0.09	_	0.20	
D	2.90	3.00	3.10	
Е	6.40 BSC			
E1	4.30	4.40	4.50	
е	0.65 BSC			
L	0.45	0.60	0.75	
θ	0°	_	8°	

Dimensions in inches

Symbols	Min.	Nom.	Max.
Α		_	0.047
A1	0.002	_	0.006
A2	0.031	0.039	0.041
b	0.007	_	0.012
С	0.004	_	0.008
D	0.114	0.118	0.122
Е	0	С	
E1	0.169	0.173	0.177
е	0	.026 BS	С
L	0.018	0.024	0.030
θ	0 °	_	8°

NOTES:

- 1. All dimensions are in millimeters.
- 2. Dimensions are inclusive of plating
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils.
- 4. Dimension L is measured in gauge plane.
- 5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.





Ordering and Marking Information

Device Marking: 2810EH2

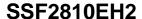
Package (Available)
TSSOP-8
Operating Temperature Range
C: -55 to 150 °C

Devices per Unit

Package	Units/	Tubes/Inner	Units/Inner	Inner	Units/Carton
Type	Tube	Box	Box	Boxes/Carton	Box
				Box	

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _j =150℃ @ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			





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